

#### **WPM3407**

# Single P-Channel, -30 V, -4.4A, Power MOSFET

# **Description**

The WPM3407 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in DC-DC conversion applications. Standard Product WPM3407 is Pb-free.

#### **Features**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Typ			
-30 V	36 m Ω @ −10 V			
30 <b>v</b>	53 m Ω @ -4.5 V			

## **Application**

- Power Management in Note book
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch

ABSOLUTE MAXIMUM RATINGS T <sub>A</sub> = 25 °C, unless otherwise noted						
Parameter	Symbol	10 S	Steady State	Unit		
Drain-Source Voltage	V <sub>DS</sub>	-30		V		
Gate-Source Voltag	V <sub>GS</sub>	±20				
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> =25°C	- I <sub>D</sub>	-4.4	- 3.7	Α	
	T <sub>A</sub> =70°C		-3.5	-2.9		
Pulsed Drain Curre	I <sub>DM</sub>					
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> =25°C	0	1.4	1.0	W	
	T <sub>A</sub> =70°C	P <sub>D</sub>	0.9	0.6	VV	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to 150		°C	

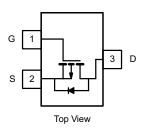
#### Http://www.sh-willsemi.com



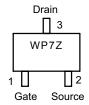
**SOT 23-3** 

pin connections:

#### P-Channel



#### Marking:



W P7= Specific Device Code Z = Date Code

#### **Order information**

Part Number	Package	Shipping
WPM3407-3/TR	SOT23-3	3000Tape&Reel



THERMAL RESISTANCE RATINGS						
Parameter			Typical	Maximum	Unit	
Junction-to-Ambient Thermal Resistance <sup>a</sup>	t ≤ 10 s	В	70	90	°C/W	
	Steady State	$R_{\theta JA}$	90	125		
Junction-to-Case Thermal Resistance	Steady State	$R_{\theta JC}$	50	80		

a. Surface Mounted on FR4 Board using 1 in sq pad size, 1oz Cu.

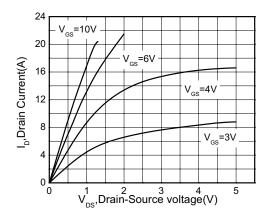
# $\pmb{Electrical\ Characteristics}\ (T_{\text{\tiny J}} = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
Static Parameters							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA		-30			V
Zone Onto Vallance Paris Occasion		$V_{DS}$ = 2 4 V , $V_{GS}$ = 0 V $T_{J}$ = 25°C $T_{J}$ = 85°C			-1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>				-10	μA	
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V				±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}$ , $I_D = -2$	250 μΑ	-1.0	-2.0	-3.0	V
Paris and the Confederation of		V <sub>GS</sub> = -10V, I <sub>D</sub> =	-4.4A		36	46	0
Drain-source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5, I <sub>D</sub> =	:-3.0A		53	66	mΩ
Forward Recovery Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> =-	1.0A	-0.5	-0.79	-1.5	V
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = -5.0 V, I <sub>D</sub>	= -5 A	5	8		S
Dynamic	'						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -15 V		700	950	1200	
Output Capacitance	C <sub>oss</sub>			90	120	150	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			75	100	125	
Total Gate Charge	Q <sub>g(tot)</sub>	V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -15 V, I <sub>D</sub> =-5 A		13	18	23	
Threshold Gate Charge	Q <sub>g(th)</sub>			1.5	2	2.5	
Gate- Source Charge	$Q_{gs}$			2	2.5	3	nC
Gate- Drain Charge	$Q_{gd}$			3	3.8	4.5	
Gate Resistance	$R_g$	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 V, f = 1.0 MHz			5	8	Ω
Switching Parameters							
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS}$ = -10 V, $V_{DS}$ = -15 V, $I_{D}$ =-4.3A, $R_{G}$ =6 $\Omega$		8	11	15	
Rise Time	t <sub>r</sub>			4	6	9	
Turn-Off Delay Time	t <sub>d(off)</sub>			30	40	50	ns
Fall Time	t <sub>f</sub>			5	7.5	10	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =-5A, dI/dt=100A/μs			25		ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> =-5A, dI/dt=100A/μs			14		nC

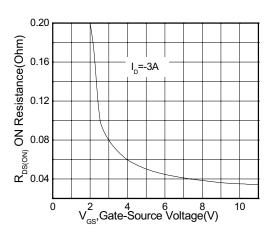
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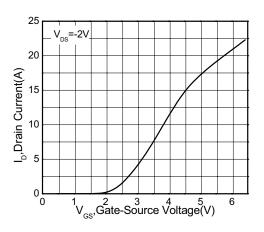
# **Typical Performance Characteristis**



**Drain Current VS Drain-Source voltage** 

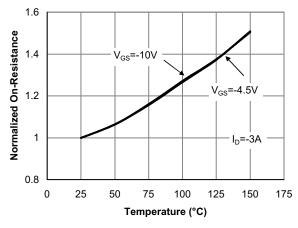


Drain Current vs ON Resistance



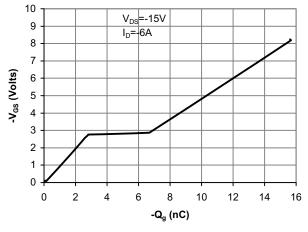
Gate-Source Voltage vs ON Resistance

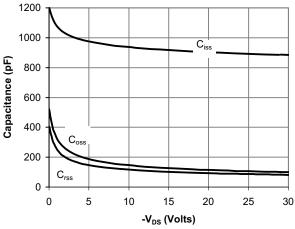
**Drain Current VS Gate-Source Voltage** 



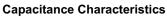
On-Resistance vs. Junction

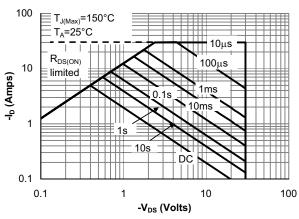


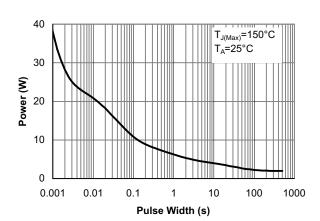




**Gate-Charge Characteristics** 

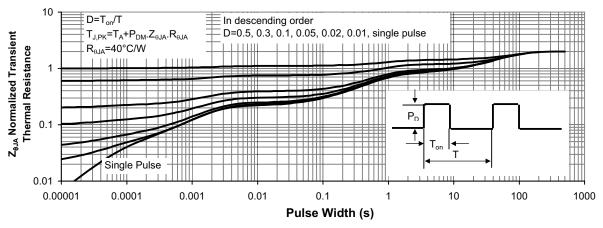






Maximum Forward Biased Safe Operating Area (Note E)

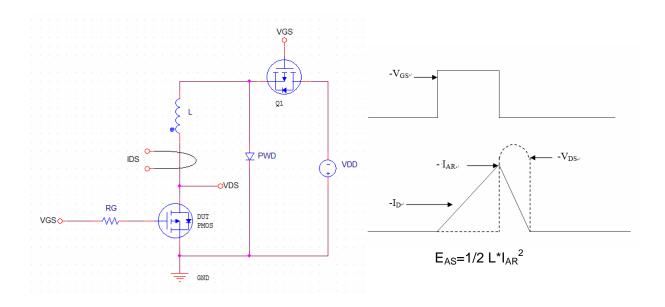
Single Pulse Power Rating Junction-to-Ambient (Note E)



**Normalized Maximum Transient Thermal Impedance** 



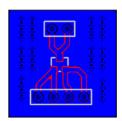
# Avalanche Energy(Single pulsed) Test Circuit & Waveforms





### **Power Dissipation Characteristics**

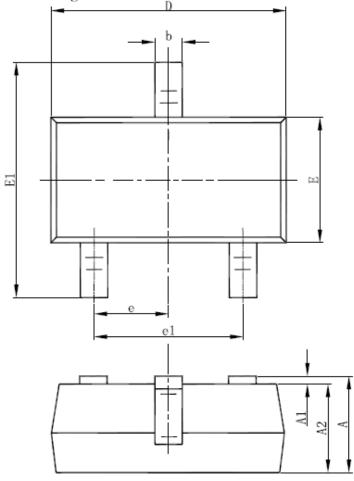
- 1. The package of WPM3407 is SOT23-3, surface mounted on FR4 Board using 1 in sq pad size, 1 oz Cu, R  $_{0JA}$  is 125  $^{\circ}$ C/W.
- 2. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, and the relation between  $T_J$  and  $P_D$  is  $T_J$  =  $T_a$  +  $R_{\theta JA}$ \*  $P_D$ , the maximum power dissipation is determined by  $R_{\theta JA}$ .
- 3. The R  $_{\theta JA}$  is the thermal impedance from junction to ambient, using larger PCB pad size can get smaller R  $_{\theta JA}$  and result in larger maximum power dissipation.

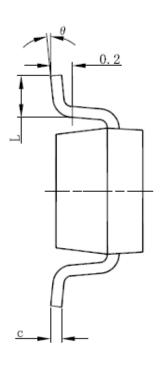


125 °C/W when mounted on a 1 in<sup>2</sup> pad of 1 oz copper.



# Packaging Information SOT-23-3 Package Outline Dimension





Dimensions		Millimeters	Dimensions	In Inches	
Symbol	Min	Max	Min	Max	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	0.950	0.950(BSC)		BSC)	
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	